

## ESD2CANxx24-Q1 适用于车载网络的 汽车类 24V、2 通道 ESD 保护二极管

### 1 特性

- IEC 61000-4-2 4 级 ESD 保护 :
  - $\pm 30\text{kV}$ 、 $\pm 25\text{kV}$  或  $\pm 20\text{kV}$  接触放电
  - $\pm 30\text{kV}$ 、 $\pm 25\text{kV}$  或  $\pm 20\text{kV}$  气隙放电
- ISO 10605 ( 330pF, 330  $\Omega$  ) ESD 保护 :
  - $\pm 30\text{kV}$ 、 $\pm 25\text{kV}$  或  $\pm 20\text{kV}$  接触放电
  - $\pm 30\text{kV}$ 、 $\pm 25\text{kV}$  或  $\pm 20\text{kV}$  气隙放电
- 经测试符合 IEC 61000-4-5
- 24V 工作电压
- 双向 ESD 保护
- 2 通道器件通过单个组件实现完整的 ESD 保护
- 低钳位电压可保护下游组件
- 符合 AEC-Q101 标准
- I/O 电容 = 3pF、2.5pF 或 1.7pF ( 典型值 )
- SOT-23 (DBZ) 小型、标准、通用封装
- SOT-323、SC-70 (DCK) 超小、标准、节省空间、通用封装
- 引线式封装, 用于自动光学检测 (AOI)

### 2 应用

- **汽车车载网络** :
  - 控制器局域网 (CAN)
  - 控制器局域网灵活数据速率 (CAN-FD)
  - 低速容错 CAN
  - 高速 CAN
- **工业控制网络** :
  - DeviceNet IEC 62026-3
  - CANopen - CiA 301/302-2 和 EN 50325-4

### 3 说明

ESD2CANxx24-Q1 是一款用于控制器局域网 (CAN) 接口保护的双向 ESD 保护二极管。ESD2CANxx24-Q1 的额定消散接触 ESD 冲击能力超过了 ISO 10605 汽车标准所规定的最高水平 (  $\pm 30\text{kV}$  接触放电,  $\pm 30\text{kV}$  气隙放电 )。低动态电阻和低钳位电压支持针对瞬态事件提供系统级保护。这种保护很关键, 因为汽车系统对安全应用的稳健性和可靠性要求很高。

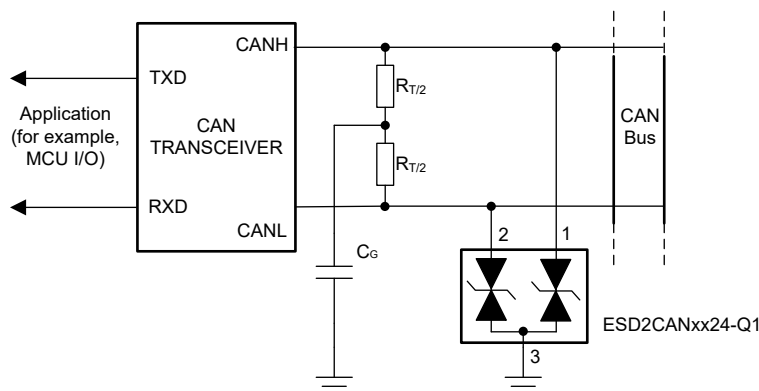
该器件具有每通道低 IO 电容和引脚排列, 以便适合两条汽车 CAN 总线 ( CANH 和 CANL ), 防止因静电放电 (ESD) 和其他瞬变造成损坏。此外, ESD2CANxx24-Q1 的 3pF ( 典型值 ) 或更小线路电容适合 CAN、CANFD、CAN SiC 和支持高达 10Mbps 数据速率的 CAN-XL 应用。

ESD2CANxx24-Q1 采用两种引线式封装, 以便轻松实现直通式路由。

#### 封装信息<sup>(1)</sup>

| 器件型号           | 封装                | 封装尺寸 ( 标称值 )           |
|----------------|-------------------|------------------------|
| ESD2CAN24-Q1   | DBZ ( SOT-23, 3 ) | 2.92mm $\times$ 1.30mm |
|                | DCK ( SC-70, 3 )  | 2.00mm $\times$ 1.25mm |
| ESD2CANFD24-Q1 | DBZ ( SOT-23, 3 ) | 2.92mm $\times$ 1.30mm |
| ESD2CANXL24-Q1 | DBZ ( SOT-23, 3 ) | 2.92mm $\times$ 1.30mm |

(1) 如需了解所有可用封装, 请参阅产品说明书末尾的可订购产品附录。



ESD2CANxx24-Q1 典型应用



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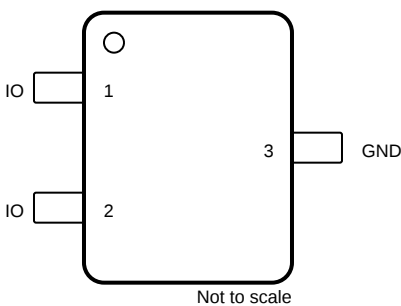
## 4 Revision History

注：以前版本的页码可能与当前版本的页码不同

| Changes from Revision B (September 2022) to Revision C (November 2022) | Page      |
|------------------------------------------------------------------------|-----------|
| • 将 ESD2CANFD24-Q1 和 ESD2CANXL24-Q1 器件状态从 预发布 更改为 正在供货 .....           | <b>1</b>  |
| • Added the <i>Application Curves</i> section.....                     | <b>14</b> |

| Changes from Revision A (June 2022) to Revision B (September 2022) | Page     |
|--------------------------------------------------------------------|----------|
| • 将数据表状态从 预告信息 更改为 量产数据 .....                                      | <b>1</b> |

## 5 Pin Configuration and Functions



**图 5-1. DCK or DBZ Package, 3-Pin SC-70 or SOT-23 (Top View)**

**表 5-1. Pin Functions**

| PIN  |      | TYPE <sup>(1)</sup> | DESCRIPTION        |
|------|------|---------------------|--------------------|
| NAME | NO.  |                     |                    |
| IO   | 1, 2 | I/O                 | ESD protected IO   |
| GND  | 3    | G                   | Connect to ground. |

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

| Parameter        |                                                          | DEVICE         | MIN | MAX | UNIT |
|------------------|----------------------------------------------------------|----------------|-----|-----|------|
| P <sub>PP</sub>  | IEC 61000-4-5 Power (t <sub>p</sub> – 8/20 μs) at 25°C   | ESD2CAN24-Q1   |     | 210 | W    |
|                  |                                                          | ESD2CANFD24-Q1 |     | 133 |      |
|                  |                                                          | ESD2CANXL24-Q1 |     | 90  |      |
| I <sub>PP</sub>  | IEC 61000-4-5 current (t <sub>p</sub> – 8/20 μs) at 25°C | ESD2CAN24-Q1   |     | 5.7 | A    |
|                  |                                                          | ESD2CANFD24-Q1 |     | 3.5 |      |
|                  |                                                          | ESD2CANXL24-Q1 |     | 2.5 |      |
| T <sub>A</sub>   | Operating free-air temperature                           |                | -55 | 150 | °C   |
| T <sub>J</sub>   | Junction temperature                                     |                | -55 | 150 |      |
| T <sub>stg</sub> | Storage temperature                                      |                | -65 | 155 |      |

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 6.2 ESD Ratings—AEC Specification

| Parameter          |                         | Test Conditions                                             | VALUE  | UNIT |
|--------------------|-------------------------|-------------------------------------------------------------|--------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per AEC Q101-001 <sup>(1)</sup>     | ± 2500 | V    |
|                    |                         | Charged device model (CDM), per AEC Q101-005 <sup>(2)</sup> | ± 1000 |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 ESD Ratings—IEC Specification

over T<sub>A</sub> = 25°C (unless otherwise noted)

| Parameter          |                         | Test Conditions                           | DEVICE         | VALUE  | UNIT |
|--------------------|-------------------------|-------------------------------------------|----------------|--------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | IEC 61000-4-2 Contact Discharge, all pins | ESD2CAN24-Q1   | ±30000 | V    |
|                    |                         |                                           | ESD2CANFD24-Q1 | ±25000 |      |
|                    |                         |                                           | ESD2CANXL24-Q1 | ±20000 |      |
|                    |                         | IEC 61000-4-2 Air-gap Discharge, all pins | ESD2CAN24-Q1   | ±30000 |      |
|                    |                         |                                           | ESD2CANFD24-Q1 | ±25000 |      |
|                    |                         |                                           | ESD2CANXL24-Q1 | ±20000 |      |

## 6.4 ESD Ratings - ISO Specification

over  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

| Parameter        |                         |                   | Test Conditions                       | DEVICE         | VALUE       | UNIT |
|------------------|-------------------------|-------------------|---------------------------------------|----------------|-------------|------|
| $V_{\text{ESD}}$ | Electrostatic discharge | Contact discharge | ISO 10605, 150-pF, 330- $\Omega$ , IO | ESD2CAN24-Q1   | $\pm 30000$ | V    |
|                  |                         |                   |                                       | ESD2CANFD24-Q1 | $\pm 25000$ |      |
|                  |                         |                   |                                       | ESD2CANXL24-Q1 | $\pm 20000$ |      |
|                  |                         |                   | ISO 10605, 330-pF, 330- $\Omega$ , IO | ESD2CAN24-Q1   | $\pm 30000$ |      |
|                  |                         |                   |                                       | ESD2CANFD24-Q1 | $\pm 25000$ |      |
|                  |                         |                   |                                       | ESD2CANXL24-Q1 | $\pm 20000$ |      |
|                  |                         | Air-gap discharge | ISO 10605, 150-pF, 330- $\Omega$ , IO | ESD2CAN24-Q1   | $\pm 30000$ |      |
|                  |                         |                   |                                       | ESD2CANFD24-Q1 | $\pm 25000$ |      |
|                  |                         |                   |                                       | ESD2CANXL24-Q1 | $\pm 20000$ |      |
|                  |                         |                   | ISO 10605, 330-pF, 330- $\Omega$ , IO | ESD2CAN24-Q1   | $\pm 30000$ |      |
|                  |                         |                   |                                       | ESD2CANFD24-Q1 | $\pm 25000$ |      |
|                  |                         |                   |                                       | ESD2CANXL24-Q1 | $\pm 20000$ |      |

## 6.5 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| Parameter       |                                | MIN | NOM | MAX | UNIT             |
|-----------------|--------------------------------|-----|-----|-----|------------------|
| $V_{\text{IN}}$ | Input voltage                  | -24 |     | 24  | V                |
| $T_A$           | Operating free-air temperature | -55 |     | 150 | $^\circ\text{C}$ |

## 6.6 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | ESD2CAN24-Q1 |                       | ESD2CANFD24-Q1 | ESD2CANXL24-Q1 | UNIT               |
|-------------------------------|----------------------------------------------|--------------|-----------------------|----------------|----------------|--------------------|
|                               |                                              | DBZ (SOT-23) | DCK (SOT-323 / SC-70) | DBZ (SOT-23)   | DBZ (SOT-23)   |                    |
|                               |                                              | 3 PINS       | 3 PINS                | 3 PINS         | 3 PINS         |                    |
| $R_{\theta \text{ JA}}$       | Junction-to-ambient thermal resistance       | 291.5        | 283.0                 | 316.3          | 325.3          | $^\circ\text{C/W}$ |
| $R_{\theta \text{ JC(top)}}$  | Junction-to-case (top) thermal resistance    | 147.1        | 164.1                 | 170.7          | 178.8          | $^\circ\text{C/W}$ |
| $R_{\theta \text{ JB}}$       | Junction-to-board thermal resistance         | 131.1        | 105.1                 | 156.2          | 165.5          | $^\circ\text{C/W}$ |
| $\Psi_{\text{JT}}$            | Junction-to-top characterization parameter   | 32.0         | 67.1                  | 45.9           | 52.4           | $^\circ\text{C/W}$ |
| $\Psi_{\text{JB}}$            | Junction-to-board characterization parameter | 130.2        | 104.4                 | 155.1          | 164.4          | $^\circ\text{C/W}$ |
| $R_{\theta \text{ JC(bot)}}$  | Junction-to-case (bottom) thermal resistance | N/A          | N/A                   | N/A            | N/A            | $^\circ\text{C/W}$ |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.7 Electrical Characteristics

over  $T_A = 25^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

| PARAMETER        |                                  | TEST CONDITIONS                               | DEVICE | MIN    | TYP | MAX    | UNIT |
|------------------|----------------------------------|-----------------------------------------------|--------|--------|-----|--------|------|
| $V_{\text{RWM}}$ | Reverse stand-off voltage        |                                               |        | - 24   |     | 24     | V    |
| $V_{\text{BRF}}$ | Breakdown voltage <sup>(2)</sup> | $I_{\text{IO}} = 10 \text{ mA}$ , IO to GND   |        | 25.5   |     | 35.5   | V    |
| $V_{\text{BRR}}$ | Breakdown voltage <sup>(2)</sup> | $I_{\text{IO}} = - 10 \text{ mA}$ , IO to GND |        | - 35.5 |     | - 25.5 | V    |

over  $T_A = 25^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

| PARAMETER          |                                   | TEST CONDITIONS                                                                       | DEVICE         | MIN | TYP  | MAX | UNIT     |
|--------------------|-----------------------------------|---------------------------------------------------------------------------------------|----------------|-----|------|-----|----------|
| $V_{\text{CLAMP}}$ | Clamping voltage <sup>(3)</sup>   | $I_{\text{PP}} = 5.7 \text{ A}$ , $t_p = 8/20 \mu\text{s}$ , IO to GND                | ESD2CAN24-Q1   |     | 37   |     | V        |
|                    |                                   | $I_{\text{PP}} = 3.5 \text{ A}$ , $t_p = 8/20 \mu\text{s}$ , IO to GND                | ESD2CANFD24-Q1 |     | 37   |     |          |
|                    |                                   | $I_{\text{PP}} = 2.5 \text{ A}$ , $t_p = 8/20 \mu\text{s}$ , IO to GND                | ESD2CANXL24-Q1 |     | 36   |     |          |
| $V_{\text{CLAMP}}$ | Clamping voltage <sup>(4)</sup>   | $I_{\text{PP}} = 16 \text{ A}$ , TLP, IO to GND or GND to IO                          | ESD2CAN24-Q1   |     | 35   |     | V        |
|                    |                                   |                                                                                       | ESD2CANFD24-Q1 |     | 36   |     |          |
|                    |                                   |                                                                                       | ESD2CANXL24-Q1 |     | 38   |     |          |
| $V_{\text{Hold}}$  | Holding voltage after snapback    | TLP                                                                                   | ESD2CAN24-Q1   |     | 30   |     | V        |
|                    |                                   |                                                                                       | ESD2CANFD24-Q1 |     | 30   |     |          |
|                    |                                   |                                                                                       | ESD2CANXL24-Q1 |     | 30   |     |          |
| $I_{\text{LEAK}}$  | Leakage current                   | $V_{\text{IO}} = \pm 24 \text{ V}$ , IO to GND                                        |                | -50 | 5    | 50  | nA       |
| $R_{\text{DYN}}$   | Dynamic resistance <sup>(4)</sup> | IO to GND and GND to IO                                                               | ESD2CAN24-Q1   |     | 0.35 |     | $\Omega$ |
|                    |                                   |                                                                                       | ESD2CANFD24-Q1 |     | 0.45 |     | $\Omega$ |
|                    |                                   |                                                                                       | ESD2CANXL24-Q1 |     | 0.57 |     | $\Omega$ |
| $C_L$              | Line capacitance <sup>(5)</sup>   | $V_{\text{IO}} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ , $V_{\text{pp}} = 30 \text{ mV}$ | ESD2CAN24-Q1   |     | 3    | 5   | pF       |
|                    |                                   |                                                                                       | ESD2CANFD24-Q1 |     | 2.5  | 4.2 |          |
|                    |                                   |                                                                                       | ESD2CANXL24-Q1 |     | 1.7  | 2.8 |          |

(1) Measurements made on each IO channel

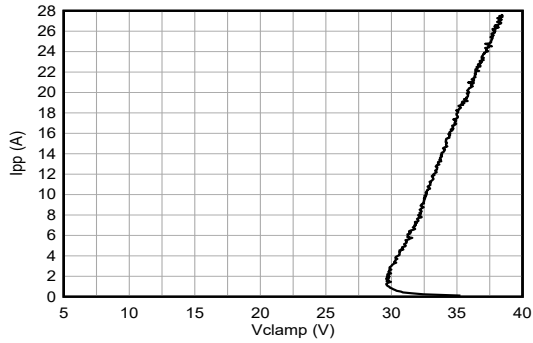
(2)  $V_{\text{BRF}}$  and  $V_{\text{BRR}}$  are defined as the voltage when  $\pm 10 \text{ mA}$  is applied in the positive and negative going direction respectively, before the device latches into the snapback state

(3) Device stressed with  $8/20 \mu\text{s}$  exponential decay waveform according to IEC 61000-4-5

(4) Non-repetitive current pulse, Transmission Line Pulse (TLP); square pulse; ANSI / ESD STM5.5.1-2008

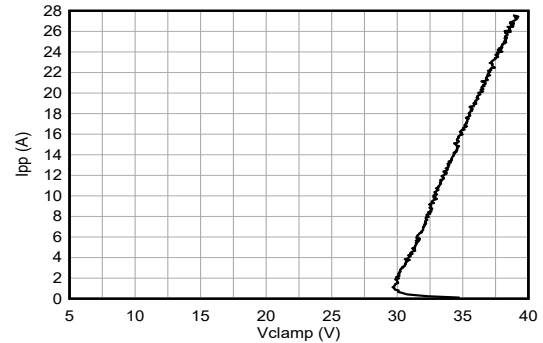
(5) Measured from IO to GND on each channel

## 6.8 Typical Characteristics – ESD2CAN24-Q1



tp = 100 ns, Transmission Line Pulse (TLP)

图 6-1. Positive TLP Curve



tp = 100 ns, Transmission Line Pulse (TLP)

图 6-2. Negative TLP Curve

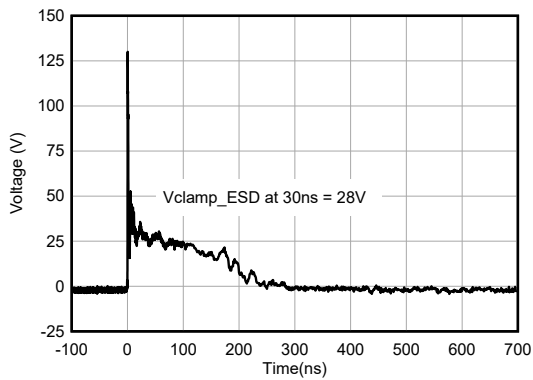


图 6-3. +8-kV Clamped IEC Waveform

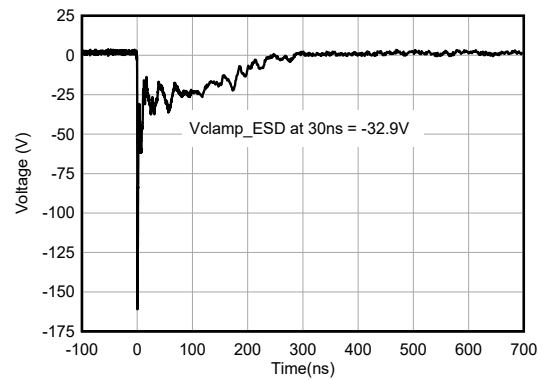


图 6-4. -8-kV Clamped IEC Waveform

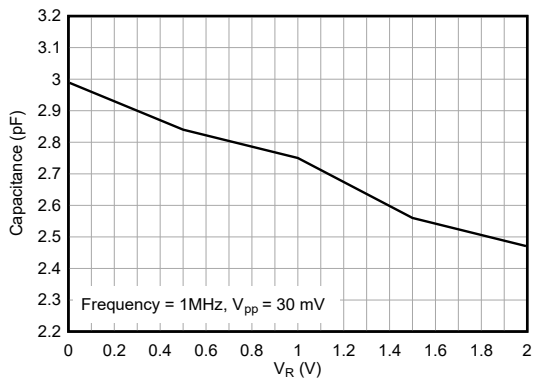
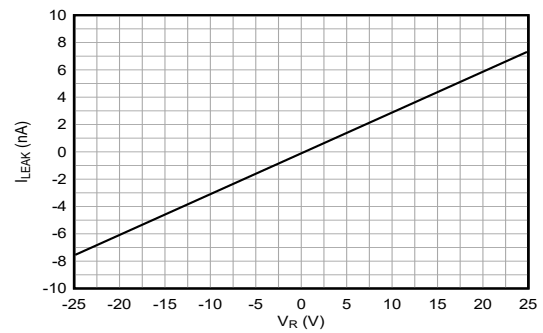


图 6-5. Capacitance vs. Bias Voltage



TA = 150 °C  
ILEAK is less than 1 nA at -55 °C and 25 °C.

图 6-6. Leakage Current vs. Bias Voltage Across Temperature

## 6.8 Typical Characteristics – ESD2CAN24-Q1 (continued)

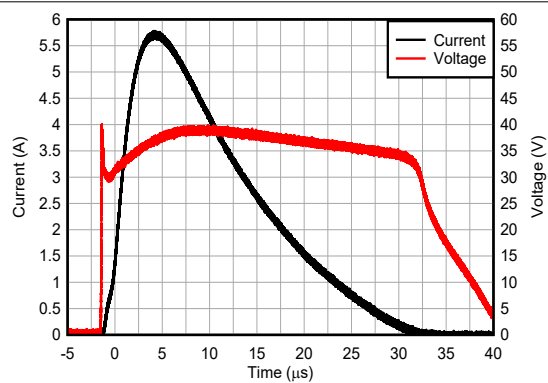
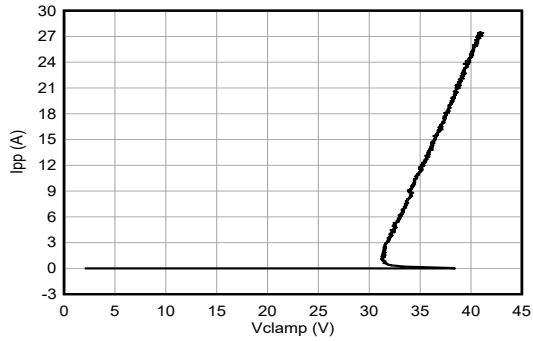


图 6-7. 8/20  $\mu\text{s}$  Surge Response at 5.7 A

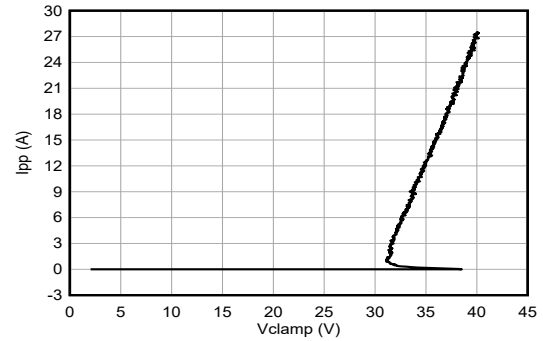


## 6.9 Typical Characteristics – ESD2CANFD24-Q1



tp = 100 ns, Transmission Line Pulse (TLP)

图 6-8. Positive TLP Curve



tp = 100 ns, Transmission Line Pulse (TLP)

图 6-9. Negative TLP Curve

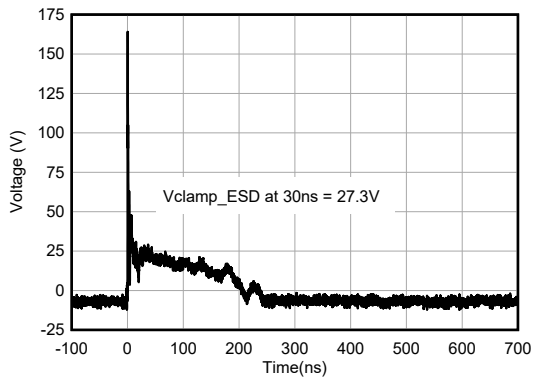


图 6-10. +8-kV Clamped IEC Waveform

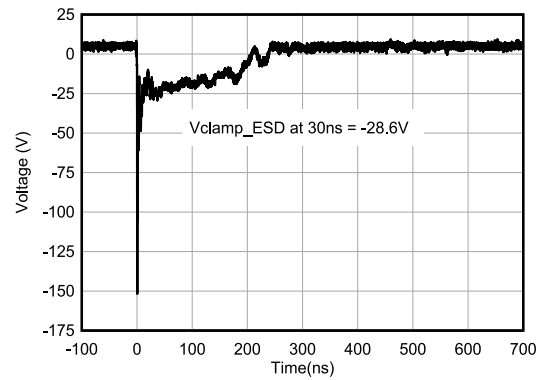


图 6-11. -8-kV Clamped IEC Waveform

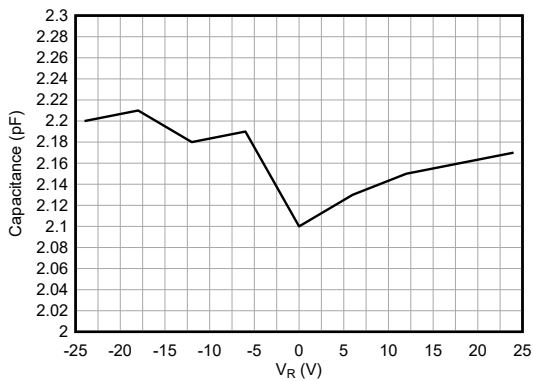
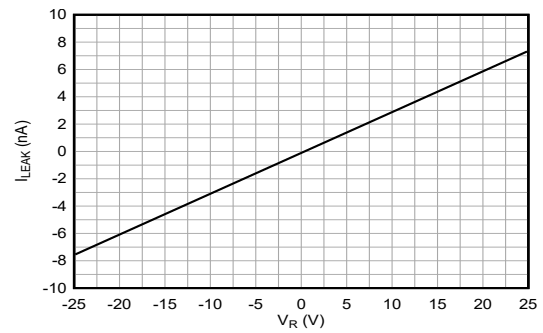


图 6-12. Capacitance vs. Bias Voltage



TA = 150 °C  
ILEAK is less than 1 nA at -55 °C and 25 °C.

图 6-13. Leakage Current vs. Bias Voltage Across Temperature

## 6.9 Typical Characteristics – ESD2CANFD24-Q1 (continued)

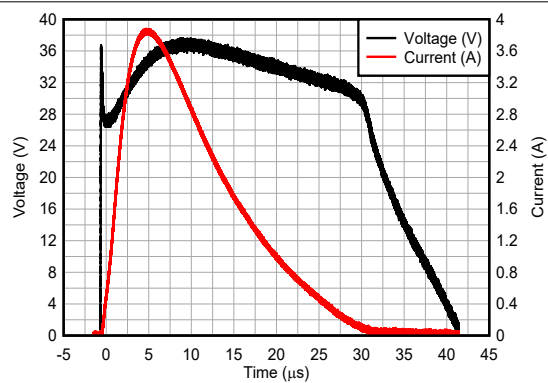


图 6-14. 8/20  $\mu\text{s}$  Surge Response at 5.7 A

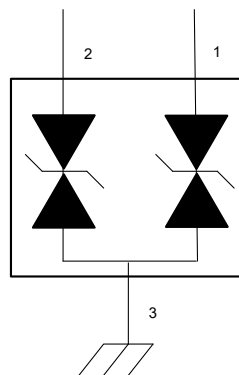
## 7 Detailed Description

### 7.1 Overview

The ESD2CANxx24-Q1 is a dual-channel ESD TVS diode in SOT-23 and SC-70 leaded packages which are convenient for automatic optical inspection. This product offers ISO 10605  $\pm 30$ -kV or  $\pm 25$ -kV or  $\pm 20$ -kV air-gap,  $\pm 30$ -kV or  $\pm 25$ -kV or  $\pm 20$ -kV contact ESD protection, and has a clamp circuit with a back-to-back TVS diode for bidirectional signal support. The 3 pF (typical) or less line capacitance of this ESD protection diode is suitable for CAN, CANFD, CAN SiC, and CAN-XL applications that can support data rates up to 10 Mbps.

A typical application for this product is ESD circuit protection for CAN transceivers used in automotive applications. The ESD2CANxx24-Q1 is a good fit for the ESD protection inside automotive electronic control units (ECUs) for head lights, door modules, climate control, roof control, wipers, cluster, audio, and many other automotive applications.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

The ESD2CANxx24-Q1 is a bidirectional TVS with a high ESD protection level. This device protects the circuit from ESD strikes up to  $\pm 30$ -kV or  $\pm 25$ -kV or  $\pm 20$ -kV contact and  $\pm 30$ -kV or  $\pm 25$ -kV or  $\pm 20$ -kV air-gap specified in the ISO 10605 automotive standard. The device can also handle up to 5.7 A surge current (IEC 61000-4-5 8/20  $\mu$ s). The I/O capacitance of 3-pF (typical) supports a data rate up to 10 Mbps. This clamping device has a small dynamic resistance, which makes the clamping voltage low when the device is actively protecting other circuits. For example, the clamping voltage is only 37 V when the device is taking 5.7 A transient surge current. The breakdown is bidirectional so this protection device is a good fit for CAN which is a differential signal. Low leakage allows the diode to conserve power when working below the  $V_{RWM}$ . The temperature range of  $-55^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$  makes this ESD device work at extensive temperatures in most environments. The leaded SOT-23 and SC-70 packages are good for applications requiring automatic optical inspection (AOI).

#### 7.3.1 AEC-Q101 Qualified and Temperature Range

This device is qualified to AEC-Q101 standards and is qualified to operate from  $-55^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ .

#### 7.3.2 ISO 10605 ESD Protection

The I/O pins can withstand ESD events of at least  $\pm 30$ -kV contact and  $\pm 30$ -kV air-gap in the leaded SOT-23 and SC-70 packages according to the ISO 10605 (330 pF and 330  $\Omega$  loading condition) standard. An ESD-surge clamp diverts the current to ground.

#### 7.3.3 IEC 61000-4-5 Surge Protection

The IO pins can withstand surge events up to 5.7 A (8/20  $\mu$ s waveform). An ESD-surge clamp diverts this current to ground.

#### 7.3.4 IO Capacitance

The capacitance between the I/O pins is 3 pF (typical) or less. This capacitance supports data rates for CAN, CANFD, CAN SiC, and CAN-XL up to 10 Mbps.

### 7.3.5 Dynamic Resistance

The IO pins feature an ESD clamp that has a low  $R_{\text{DYN}}$  of  $0.57\ \Omega$  (Pin 1 or Pin 2 to Pin 3) and  $0.57\ \Omega$  (Pin 3 to Pin 1 or Pin 2) or less which prevents system damage during ESD events.

### 7.3.6 DC Breakdown Voltage

The DC breakdown voltage between the IO pins is a minimum of  $\pm 25.5\ \text{V}$ . This protects sensitive equipment from surges above the reverse standoff voltage of  $\pm 24\ \text{V}$ .

### 7.3.7 Ultra Low Leakage Current

The IO pins feature an ultra-low leakage current of  $\pm 50\ \text{nA}$  (maximum) with a bias of  $\pm 24\ \text{V}$ .

### 7.3.8 Clamping Voltage

The IO pins feature an ESD clamp that is capable of clamping the voltage to  $37\ \text{V}$  ( $I_{\text{PP}} = 5.7\ \text{A}$ ) and  $35\ \text{V}$  ( $I_{\text{PP}} = 16\ \text{A}$  for TLP) for ESD2CAN24-Q1, and  $38\ \text{V}$  ( $I_{\text{PP}} = 3.5\ \text{A}$ ) and  $34\ \text{V}$  ( $I_{\text{PP}} = 16\ \text{A}$  for TLP) for ESD2CANFD24-Q1, and  $36\ \text{V}$  ( $I_{\text{PP}} = 1.5\ \text{A}$ ) and  $38\ \text{V}$  ( $I_{\text{PP}} = 16\ \text{A}$  for TLP) for ESD2CANXL24-Q1.

### 7.3.9 Industry Standard Leaded Packages

This device features industry standard SOT-23 (DBZ) and SC-70 (DCK) leaded packages for automatic optical inspection (AOI).

## 7.4 Device Functional Modes

The ESD2CANxx24-Q1 is a dual channel passive clamp that has low leakage during normal operation when the voltage between pin 1 or pin 2 and pin 3 is below  $V_{\text{RWM}}$ , and activates when the voltage between pin 1 or pin 2 and pin 3 goes above  $V_{\text{BR}}$ . During ISO 10605 ESD events, transient voltages as high as  $\pm 30\ \text{kV}$  can be clamped on either channel. When the voltages on the protected lines fall below the  $V_{\text{HOLD}}$ , the device reverts back to the low leakage passive state.

## 8 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 8.1 Application Information

The ESD2CANxx24-Q1 is a dual channel TVS diode which is used to provide a path to ground for dissipating ESD events on differential CAN signal lines. The CAN signal lines are typically routed throughout the automobile to connect between the different ECUs. As the current from ESD passes through the TVS, only a small voltage drop is present across the diode. This is the voltage presented to the protected IC. The low  $R_{DYN}$  of the triggered TVS holds this voltage,  $V_{CLAMP}$ , to a safe level for the protected IC.

### 8.2 Typical Application

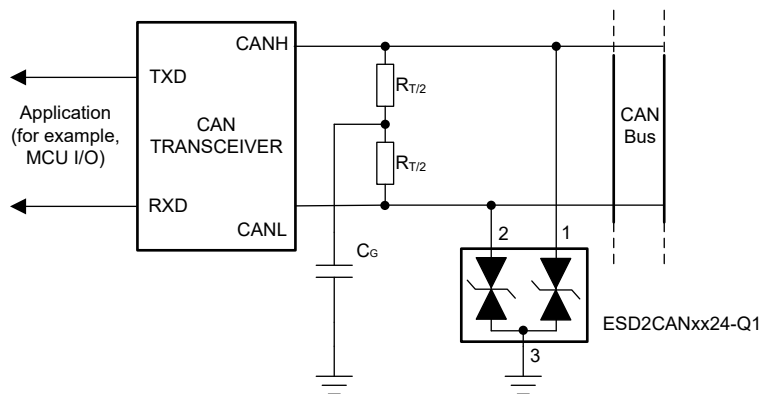


图 8-1. ESD2CANxx24-Q1 Typical Application

#### 8.2.1 Design Requirements

For this design example, the ESD2CANxx24-Q1 is used to provide ESD protection for a CAN transceiver. 表 8-1 lists the known design parameters for this application.

表 8-1. Design Parameters for the ESD2CAN24-Q1 Typical Application

| Design Parameter                             | Value         |
|----------------------------------------------|---------------|
| Diode configuration                          | Bidirectional |
| $V_{IO}$ differential signal range           | $> \pm 1.5$ V |
| $V_{RWM}$                                    | $\pm 24$ V    |
| Jumpstart short to battery event on $V_{IO}$ | $\pm 24$ V    |
| Data rate                                    | Up to 10 Mbps |
| $R_{T/2}$                                    | 60 $\Omega$   |

### 8.2.2 Detailed Design Procedure

The ESD2CANxx24-Q1 has a  $V_{RWM}$  of  $\pm 24$  V to protect the diode from being damaged during a short to battery event that can occur by reversing the terminal connections during jumpstart. The bidirectional characteristic enables the signal integrity of the differential CAN lines to not be impacted by the diode. The low capacitance of 3 pF (typical) or less enables data rates up to 10 Mbps, which allows the designer to meet the requirements for CAN, CANFD, CAN SiC, and CAN-XL. The 60  $\Omega$  split termination improves the electromagnetic emissions behavior of the network by filtering higher-frequency common-mode noise that may be present on the differential signal lines.

### 8.2.3 Application Curves

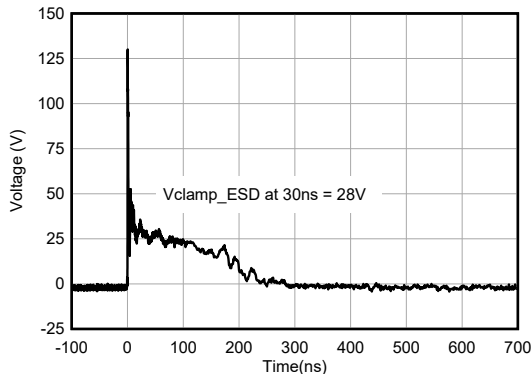


图 8-2. +8-kV Clamped IEC Waveform

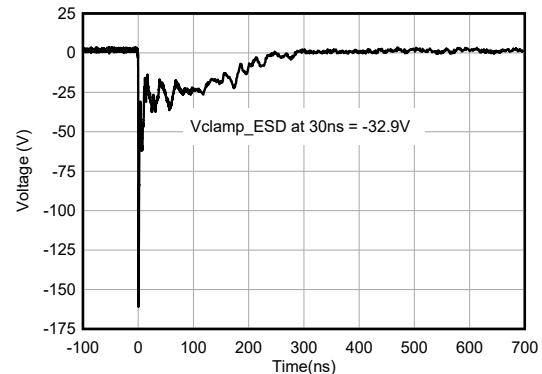


图 8-3. -8-kV Clamped IEC Waveform

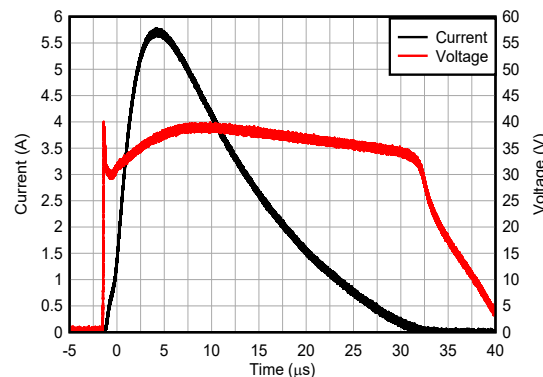


图 8-4. 8/20  $\mu$ s Surge Response at 5.7 A

## 9 Power Supply Recommendations

This device is a passive TVS diode-based ESD protection device, therefore there is no requirement to power it. Ensure that the maximum voltage specifications for each pin are not violated.

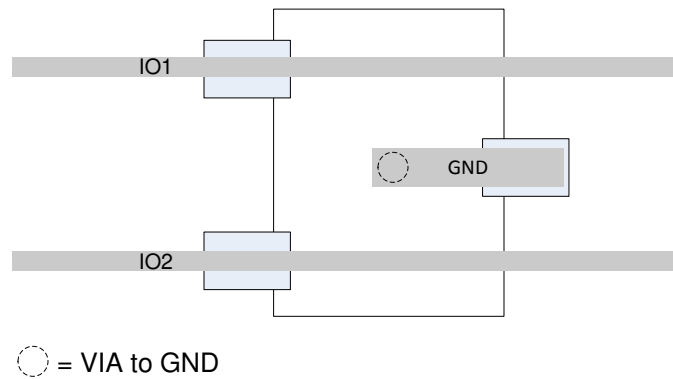
## 10 Layout

### 10.1 Layout Guidelines

- The optimum placement of the device is as close to the connector as possible.
  - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
  - The PCB designer must minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
  - Electric fields tend to build up on corners, increasing EMI coupling.
- If pin 3 is connected to ground, use a thick and short trace for this return path.

### 10.2 Layout Example

This example is typical of a dual channel differential data pair application, such as CAN.



**图 10-1. Routing with DBZ and DCK Package**

## 11 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [ESD Layout Guide user's guide](#)
- Texas Instruments, [ESD Protection Diodes EVM user's guide](#)
- Texas Instruments, [Generic ESD Evaluation Module user's guide](#)
- Texas Instruments, [Reading and Understanding an ESD Protection data sheet](#)

### 11.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 11.3 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

### 11.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

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### 11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 11.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGING INFORMATION

| Orderable Device  | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|-------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| ESD2CAN24DBZRQ1   | ACTIVE        | SOT-23       | DBZ                | 3    | 3000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -55 to 150   | 1L3                     | <a href="#">Samples</a> |
| ESD2CAN24DCKRQ1   | ACTIVE        | SC70         | DCK                | 3    | 3000           | RoHS & Green    | NIPDAU                               | Level-3-260C-168 HR  | -55 to 150   | 1L6                     | <a href="#">Samples</a> |
| ESD2CANFD24DBZRQ1 | ACTIVE        | SOT-23       | DBZ                | 3    | 3000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -55 to 150   | 2QP8                    | <a href="#">Samples</a> |
| ESD2CANXL24DBZRQ1 | ACTIVE        | SOT-23       | DBZ                | 3    | 3000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -55 to 150   | 2RI8                    | <a href="#">Samples</a> |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF ESD2CANFD24-Q1 :**

- Catalog : [ESD2CANFD24](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

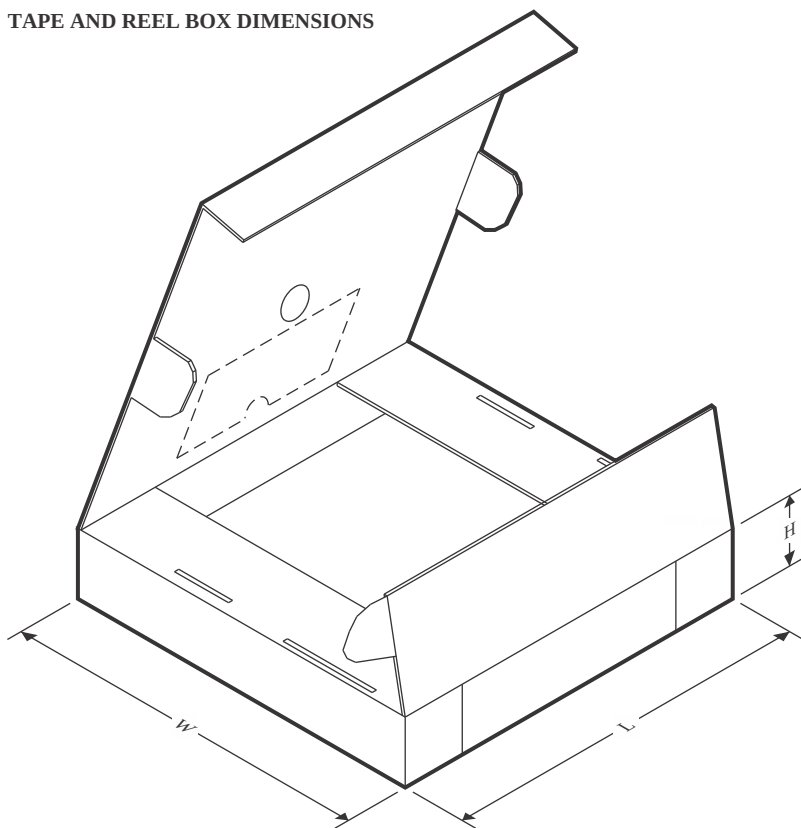
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ESD2CAN24DBZRQ1   | SOT-23       | DBZ             | 3    | 3000 | 180.0              | 8.4                | 2.9     | 3.35    | 1.35    | 4.0     | 8.0    | Q3            |
| ESD2CAN24DCKRQ1   | SC70         | DCK             | 3    | 3000 | 178.0              | 9.0                | 2.4     | 2.5     | 1.2     | 4.0     | 8.0    | Q3            |
| ESD2CANFD24DBZRQ1 | SOT-23       | DBZ             | 3    | 3000 | 180.0              | 8.4                | 2.9     | 3.35    | 1.35    | 4.0     | 8.0    | Q3            |
| ESD2CANXL24DBZRQ1 | SOT-23       | DBZ             | 3    | 3000 | 180.0              | 8.4                | 2.9     | 3.35    | 1.35    | 4.0     | 8.0    | Q3            |

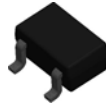
## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

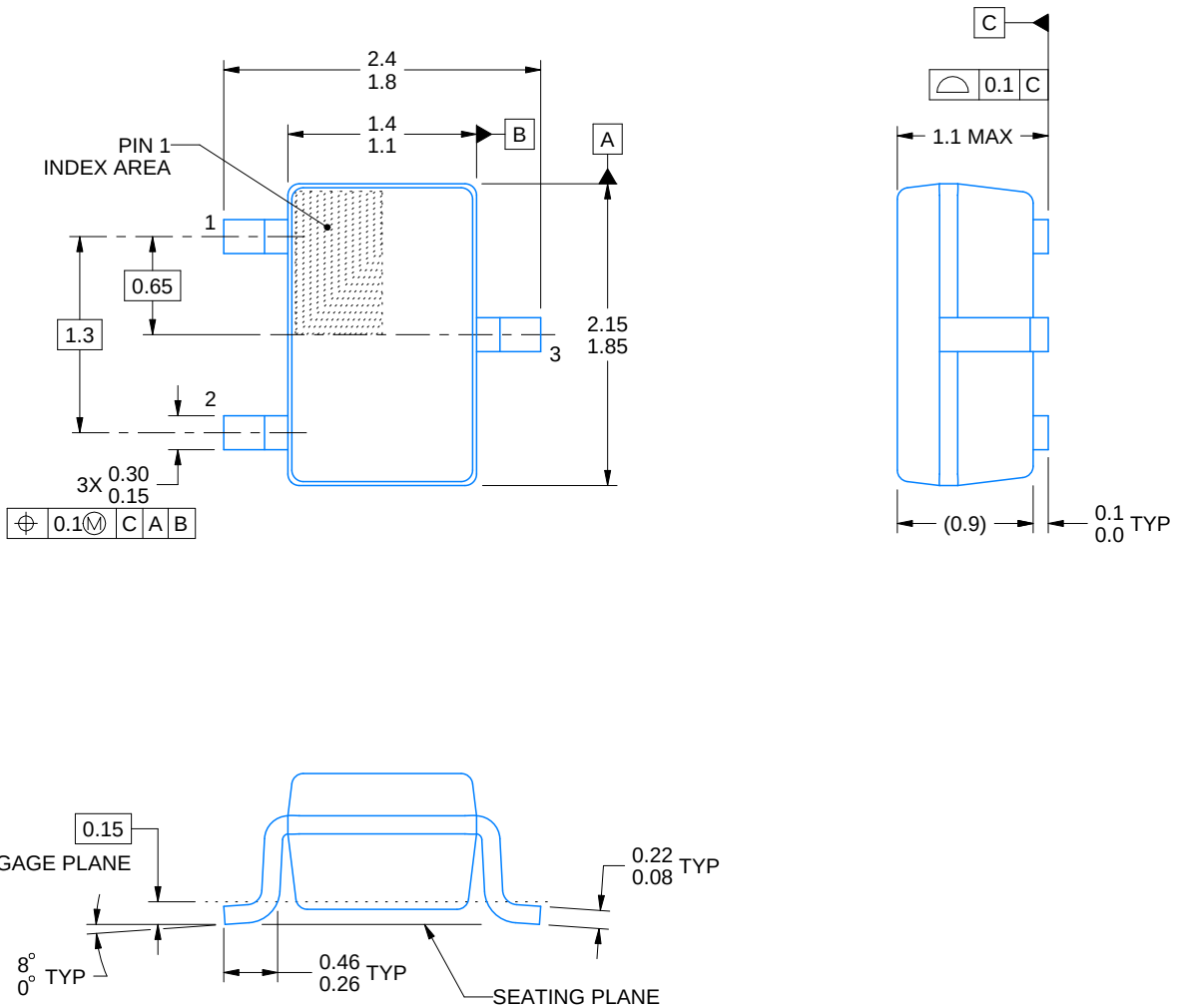
| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ESD2CAN24DBZRQ1   | SOT-23       | DBZ             | 3    | 3000 | 210.0       | 185.0      | 35.0        |
| ESD2CAN24DCKRQ1   | SC70         | DCK             | 3    | 3000 | 190.0       | 190.0      | 30.0        |
| ESD2CANFD24DBZRQ1 | SOT-23       | DBZ             | 3    | 3000 | 210.0       | 185.0      | 35.0        |
| ESD2CANXL24DBZRQ1 | SOT-23       | DBZ             | 3    | 3000 | 210.0       | 185.0      | 35.0        |

DCK0003A



**PACKAGE OUTLINE**  
**SOT-SC70 - 1.1 max height**

SMALL OUTLINE TRANSISTOR SC70



4220745/C 06/2021

**NOTES:**

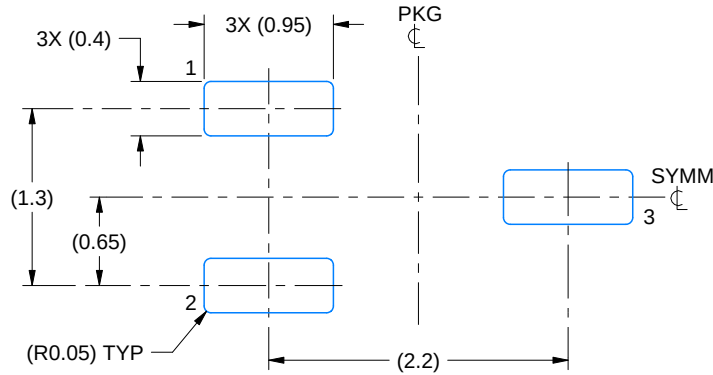
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

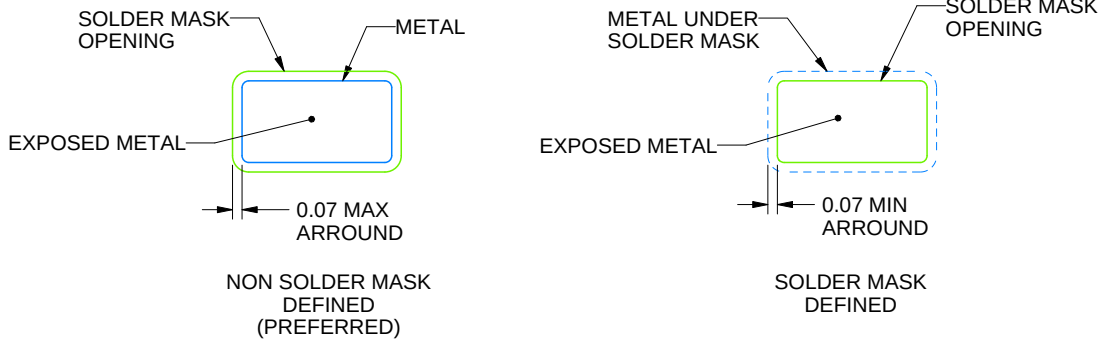
DCK0003A

SOT-SC70 - 1.1 max height

SMALL OUTLINE TRANSISTOR SC70



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:18X



SOLDER MASK DETAILS

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NOTES: (continued)

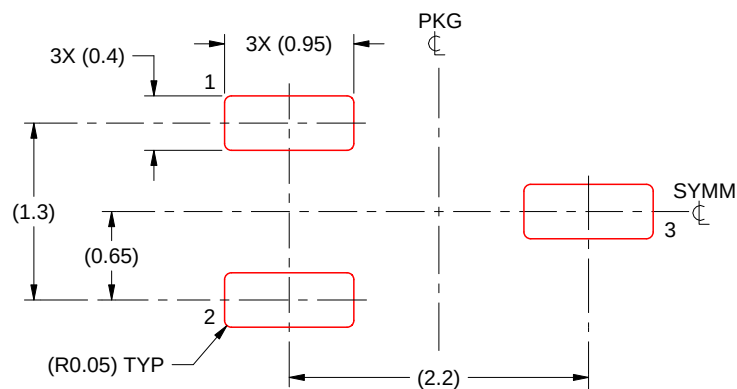
3. Publication IPC-7351 may have alternate designs.
4. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DCK0003A

SOT-SC70 - 1.1 max height

SMALL OUTLINE TRANSISTOR SC70

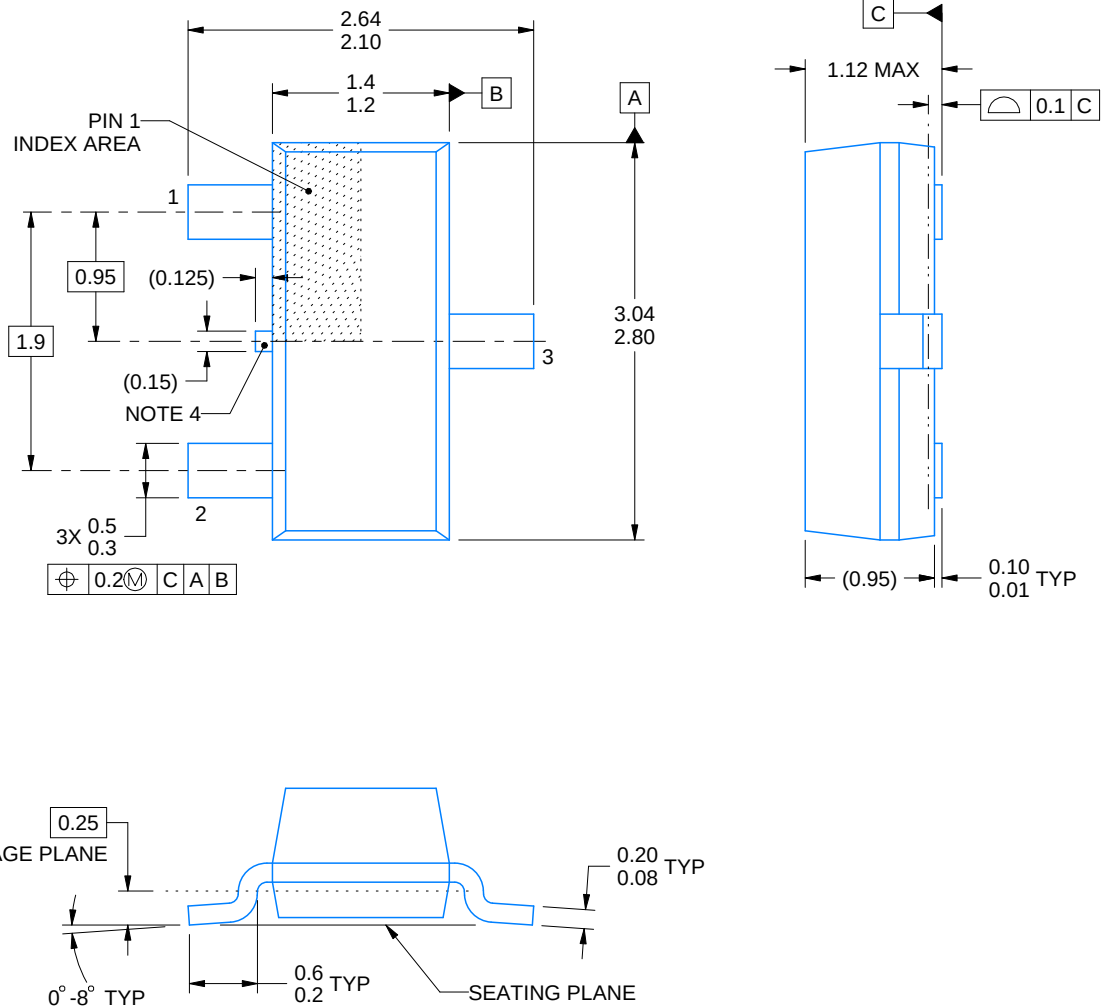


SOLDER PASTE EXAMPLE  
BASED ON 0.125 THICK STENCIL  
SCALE:18X

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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
6. Board assembly site may have different recommendations for stencil design.



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## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC registration TO-236, except minimum foot length.
4. Support pin may differ or may not be present.

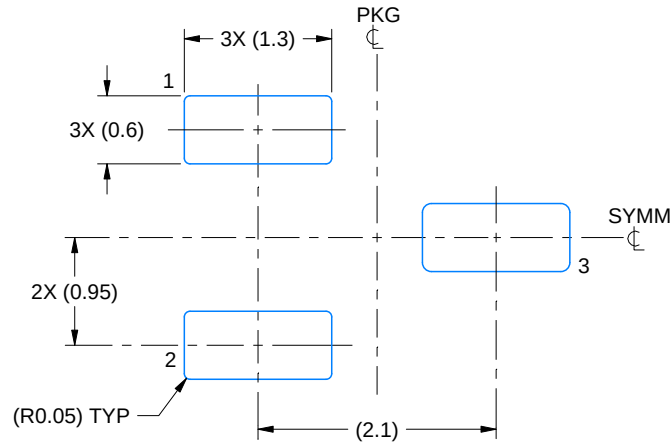


# EXAMPLE BOARD LAYOUT

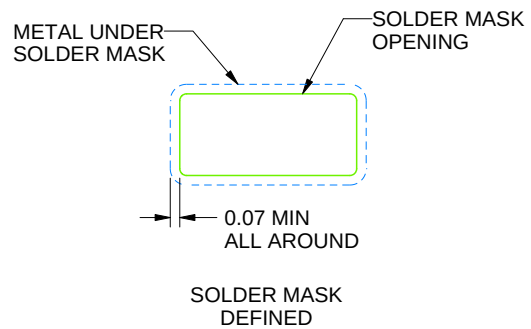
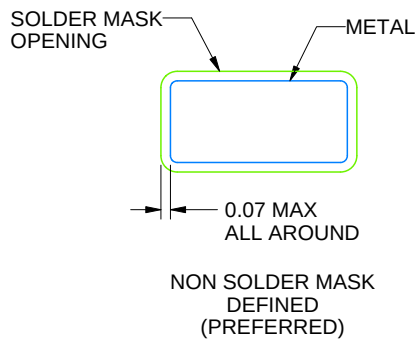
DBZ0003A

SOT-23 - 1.12 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
SCALE:15X



SOLDER MASK DETAILS

4214838/D 03/2023

NOTES: (continued)

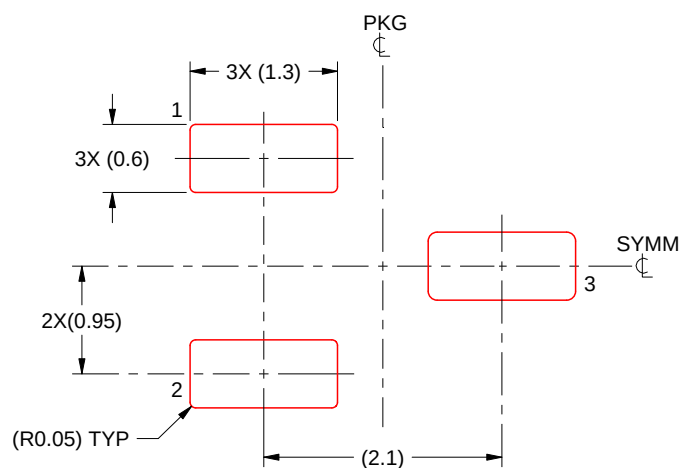
4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBZ0003A

SOT-23 - 1.12 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 THICK STENCIL  
SCALE:15X

4214838/D 03/2023

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

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